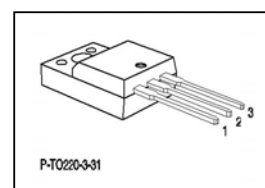


**CoolMOS™ Power Transistor**
**Features**

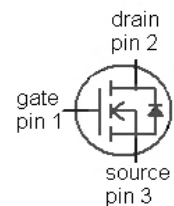
- Low gate charge
- Extreme dv/dt rated
- High peak current capability
- Qualified according to JEDEC<sup>1)</sup> for target applications
- Pb-free lead plating; RoHS compliant

**Product Summary**

|                  |      |          |
|------------------|------|----------|
| $V_{DS}$         | 650  | V        |
| $R_{DS(on),max}$ | 0.28 | $\Omega$ |
| $Q_{g,typ}$      | 63   | nC       |

**PG-TO220-3-31**


| Type       | Package       | Marking |
|------------|---------------|---------|
| SPA15N65C3 | PG-TO220-3-31 | 15N65C3 |


**Maximum ratings, at  $T_j=25\text{ °C}$ , unless otherwise specified**

| Parameter                                               | Symbol            | Conditions                              | Value       | Unit |
|---------------------------------------------------------|-------------------|-----------------------------------------|-------------|------|
| Continuous drain current <sup>2)</sup>                  | $I_D$             | $T_C=25\text{ °C}$                      | 15          | A    |
|                                                         |                   | $T_C=100\text{ °C}$                     | 9.4         |      |
| Pulsed drain current <sup>3)</sup>                      | $I_{D,pulse}$     | $T_C=25\text{ °C}$                      | 45          |      |
| Avalanche energy, single pulse                          | $E_{AS}$          | $I_D=3\text{ A}$ , $V_{DD}=50\text{ V}$ | 460         | mJ   |
| Avalanche energy, repetitive $t_{AR}$ <sup>2),3)</sup>  | $E_{AR}$          | $I_D=5\text{ A}$ , $V_{DD}=50\text{ V}$ | 0.8         |      |
| Avalanche current, repetitive $t_{AR}$ <sup>3),4)</sup> | $I_{AR}$          |                                         | 5.0         | A    |
| MOSFET dv/dt ruggedness                                 | dv/dt             | $V_{DS}=0\ldots480\text{ V}$            | 50          | V/ns |
| Gate source voltage                                     | $V_{GS}$          | static                                  | $\pm 20$    | V    |
|                                                         |                   | AC ( $f>1\text{ Hz}$ )                  | $\pm 30$    |      |
| Power dissipation                                       | $P_{tot}$         | $T_C=25\text{ °C}$                      | 34          | W    |
| Operating and storage temperature                       | $T_j$ , $T_{stg}$ |                                         | -55 ... 150 | °C   |
| Mounting torque                                         |                   | M3 and M3.5 screws                      | 50          | Ncm  |

**Maximum ratings**, at  $T_j=25\text{ °C}$ , unless otherwise specified

| Parameter                                      | Symbol        | Conditions         | Value | Unit |
|------------------------------------------------|---------------|--------------------|-------|------|
| Continuous diode forward current <sup>2)</sup> | $I_S$         | $T_C=25\text{ °C}$ | 15    | A    |
| Diode pulse current <sup>3)</sup>              | $I_{S,pulse}$ |                    | 45    |      |

| Parameter | Symbol | Conditions | Values |      |      | Unit |
|-----------|--------|------------|--------|------|------|------|
|           |        |            | min.   | typ. | max. |      |

#### Thermal characteristics

|                                                            |              |                                       |   |   |     |     |
|------------------------------------------------------------|--------------|---------------------------------------|---|---|-----|-----|
| Thermal resistance, junction - case                        | $R_{thJC}$   |                                       | - | - | 3.7 | K/W |
| Thermal resistance, junction - ambient                     | $R_{thJA}$   | leaded                                | - | - | 62  |     |
| Soldering temperature, wavesoldering only allowed at leads | $T_{solder}$ | 1.6 mm (0.063 in.) from case for 10 s | - | - | 260 | °C  |

**Electrical characteristics**, at  $T_j=25\text{ °C}$ , unless otherwise specified

#### Static characteristics

|                                  |               |                                                                      |     |      |      |               |
|----------------------------------|---------------|----------------------------------------------------------------------|-----|------|------|---------------|
| Drain-source breakdown voltage   | $V_{(BR)DSS}$ | $V_{GS}=0\text{ V}$ , $I_D=250\text{ }\mu\text{A}$                   | 650 | -    | -    | V             |
| Gate threshold voltage           | $V_{GS(th)}$  | $V_{DS}=V_{GS}$ ,<br>$I_D=0.675\text{ mA}$                           | 2.1 | 3    | 3.9  |               |
| Zero gate voltage drain current  | $I_{DSS}$     | $V_{DS}=600\text{ V}$ , $V_{GS}=0\text{ V}$ ,<br>$T_j=25\text{ °C}$  | -   | 0.5  | 25   | $\mu\text{A}$ |
|                                  |               | $V_{DS}=600\text{ V}$ , $V_{GS}=0\text{ V}$ ,<br>$T_j=150\text{ °C}$ | -2  | 5-   |      |               |
| Gate-source leakage current      | $I_{GSS}$     | $V_{GS}=20\text{ V}$ , $V_{DS}=0\text{ V}$                           | -   | -    | 100  | nA            |
| Drain-source on-state resistance | $R_{DS(on)}$  | $V_{GS}=10\text{ V}$ , $I_D=9.4\text{ A}$ ,<br>$T_j=25\text{ °C}$    | -   | 0.25 | 0.28 | $\Omega$      |
|                                  |               | $V_{GS}=10\text{ V}$ , $I_D=9.4\text{ A}$ ,<br>$T_j=150\text{ °C}$   | -   | 0.68 | -    |               |
| Gate resistance                  | $R_G$         | $f=1\text{ MHz}$ , open drain                                        | -   | 1.4  | -    | $\Omega$      |

| Parameter | Symbol | Conditions | Values |      |      | Unit |
|-----------|--------|------------|--------|------|------|------|
|           |        |            | min.   | typ. | max. |      |

**Dynamic characteristics**

|                                                            |              |                                                                                       |    |      |   |    |
|------------------------------------------------------------|--------------|---------------------------------------------------------------------------------------|----|------|---|----|
| Input capacitance                                          | $C_{iss}$    | $V_{GS}=0\text{ V}, V_{DS}=25\text{ V},$<br>$f=1\text{ MHz}$                          | -  | 1600 | - | pF |
| Output capacitance                                         | $C_{oss}$    |                                                                                       | -  | 540  | - |    |
| Effective output capacitance, energy related <sup>5)</sup> | $C_{o(er)}$  | $V_{GS}=0\text{ V}, V_{DS}=0\text{ V}$<br>to 480 V                                    | -6 | 7-   |   |    |
| Effective output capacitance, time related <sup>6)</sup>   | $C_{o(tr)}$  |                                                                                       | -  | 120  | - |    |
| Turn-on delay time                                         | $t_{d(on)}$  | $V_{DD}=400\text{ V},$<br>$V_{GS}=10\text{ V}, I_D=15\text{ A},$<br>$R_G=6.8\ \Omega$ | -3 | 2-   |   | ns |
| Rise time                                                  | $t_r$        |                                                                                       | -1 | 4-   |   |    |
| Turn-off delay time                                        | $t_{d(off)}$ |                                                                                       | -7 | 0-   |   |    |
| Fall time                                                  | $t_f$        |                                                                                       | -1 | 1-   |   |    |

**Gate Charge Characteristics**

|                       |               |                                                                             |    |     |   |    |
|-----------------------|---------------|-----------------------------------------------------------------------------|----|-----|---|----|
| Gate to source charge | $Q_{gs}$      | $V_{DD}=480\text{ V}, I_D=15\text{ A},$<br>$V_{GS}=0\text{ to }10\text{ V}$ | -9 |     | - | nC |
| Gate to drain charge  | $Q_{gd}$      |                                                                             | -2 | 9-  |   |    |
| Gate charge total     | $Q_g$         |                                                                             | -6 | 3   |   |    |
| Gate plateau voltage  | $V_{plateau}$ |                                                                             | -  | 5.4 | - | V  |

**Reverse Diode**

|                               |           |                                                                    |    |     |     |               |
|-------------------------------|-----------|--------------------------------------------------------------------|----|-----|-----|---------------|
| Diode forward voltage         | $V_{SD}$  | $V_{GS}=0\text{ V}, I_F=15\text{ A},$<br>$T_j=25\text{ °C}$        | -  | 1.0 | 1.2 | V             |
| Reverse recovery time         | $t_{rr}$  | $V_R=480\text{ V}, I_F=I_S,$<br>$di_F/dt=100\text{ A/}\mu\text{s}$ | -  | 420 | -   | ns            |
| Reverse recovery charge       | $Q_{rr}$  |                                                                    | -8 |     | -   | $\mu\text{C}$ |
| Peak reverse recovery current | $I_{rrm}$ |                                                                    | -3 | 2-  |     | A             |

<sup>1)</sup> J-STD20 and JESD22

<sup>2)</sup> Limited only by maximum temperature.

<sup>3)</sup> Pulse width  $t_p$  limited by  $T_{j,max}$

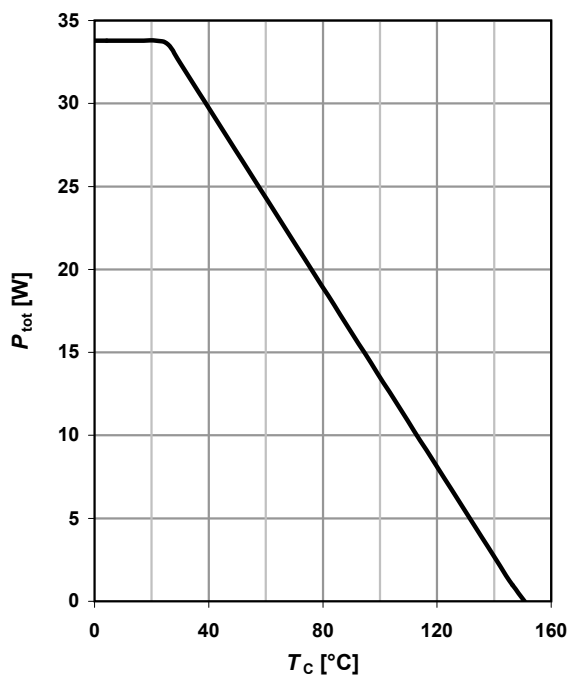
<sup>4)</sup> Repetitive avalanche causes additional power losses that can be calculated as  $P_{AV}=E_{AR} \cdot f$ .

<sup>5)</sup>  $C_{o(er)}$  is a fixed capacitance that gives the same stored energy as  $C_{oss}$  while  $V_{DS}$  is rising from 0 to 80%  $V_{DSS}$ .

<sup>6)</sup>  $C_{o(tr)}$  is a fixed capacitance that gives the same charging time as  $C_{oss}$  while  $V_{DS}$  is rising from 0 to 80%  $V_{DSS}$ .

## 1 Power dissipation

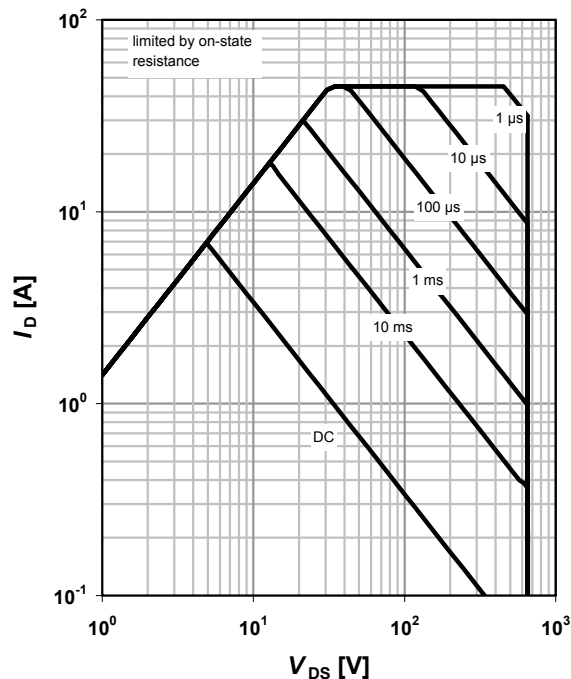
$$P_{\text{tot}} = f(T_C)$$



## 2 Safe operating area

$$I_D = f(V_{DS}); T_C = 25^\circ\text{C}; D = 0$$

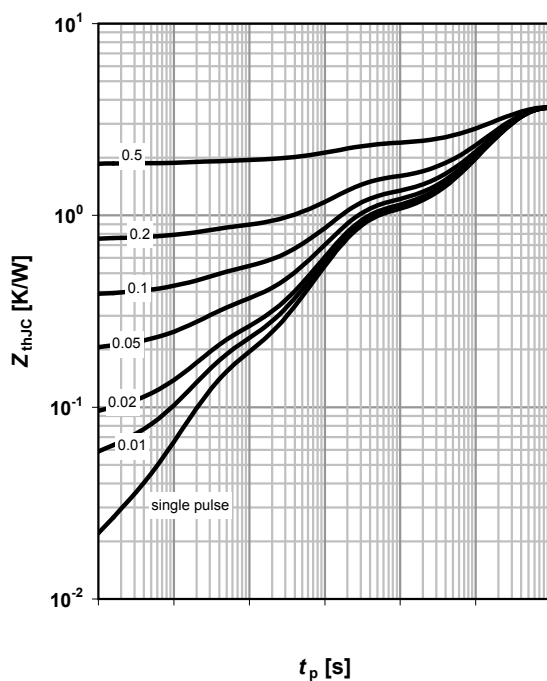
parameter:  $t_p$



## 3 Max. transient thermal impedance

$$Z_{\text{thJC}} = f(t_p)$$

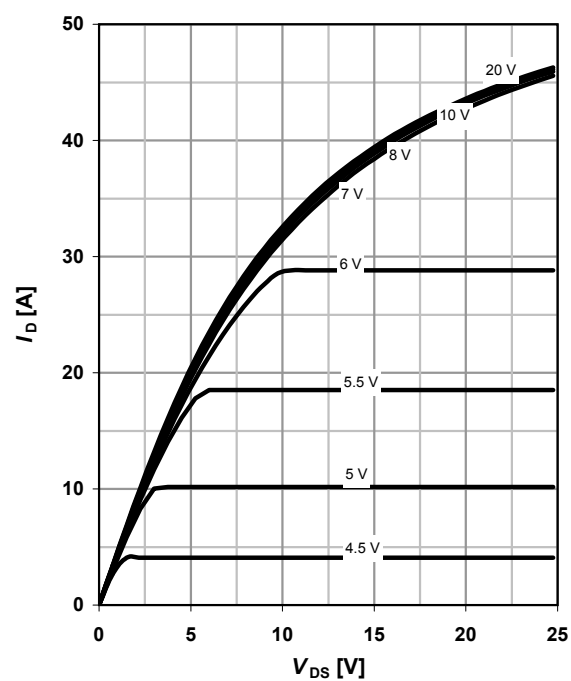
parameter:  $D = t_p / T$



## 4 Typ. output characteristics

$$I_D = f(V_{DS}); T_J = 25^\circ\text{C}$$

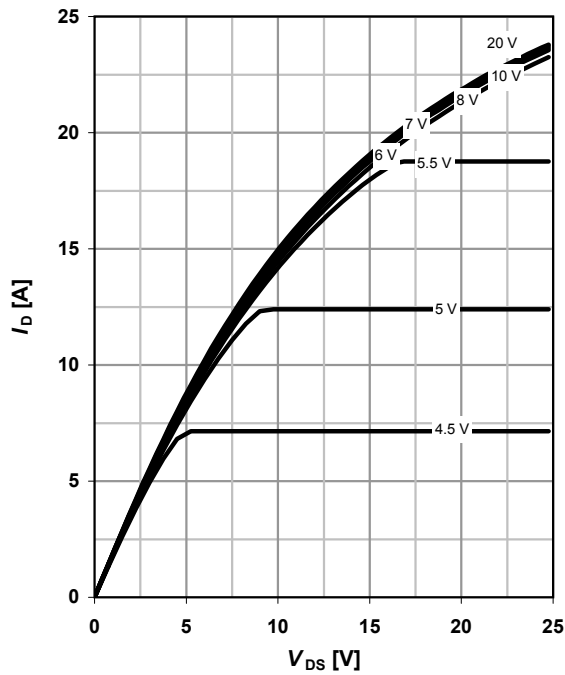
parameter:  $V_{GS}$



### 5 Typ. output characteristics

$$I_D = f(V_{DS}); T_j = 150^\circ\text{C}$$

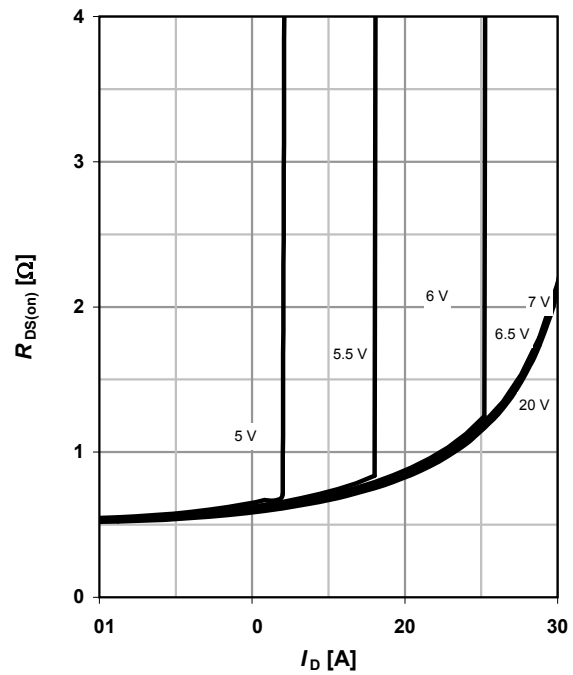
parameter:  $V_{GS}$



### 6 Typ. drain-source on-state resistance

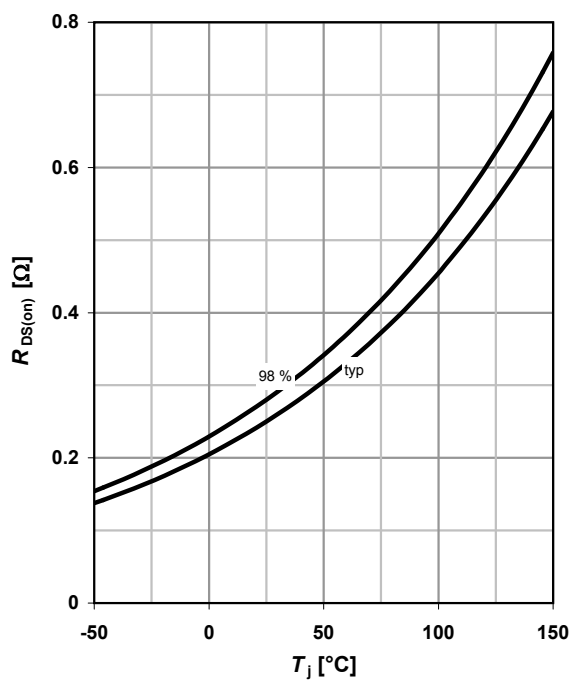
$$R_{DS(on)} = f(I_D); T_j = 150^\circ\text{C}$$

parameter:  $V_{GS}$



### 7 Drain-source on-state resistance

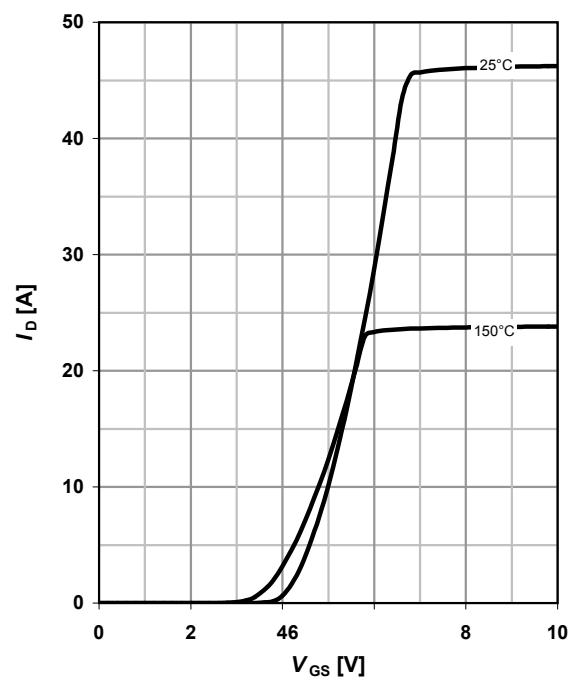
$$R_{DS(on)} = f(T_j); I_D = 9.4\text{ A}; V_{GS} = 10\text{ V}$$



### 8 Typ. transfer characteristics

$$I_D = f(V_{GS}); |V_{DS}| > 2|I_D|/R_{DS(on)\max}$$

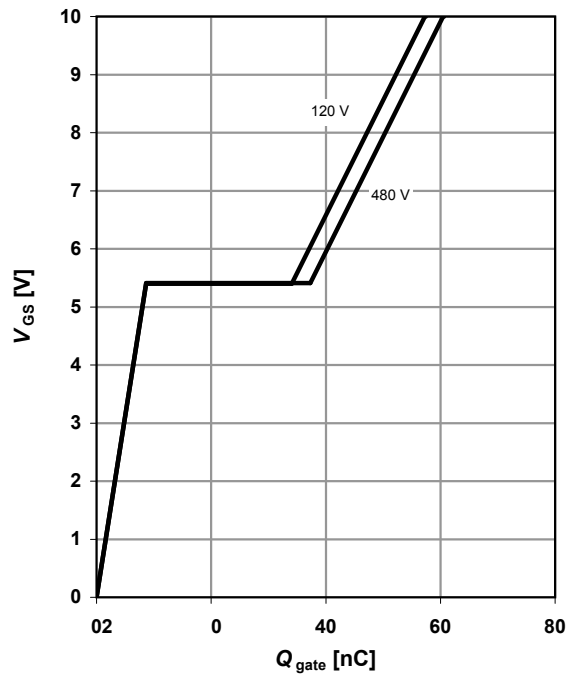
parameter:  $T_j$



### 9 Typ. gate charge

$$V_{GS}=f(Q_{gate}); I_D=15\text{ A pulsed}$$

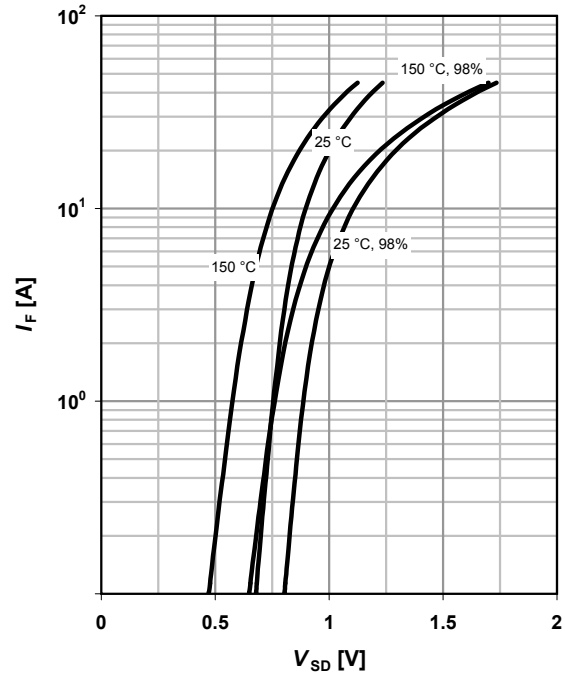
parameter:  $V_{DD}$



### 10 Forward characteristics of reverse diode

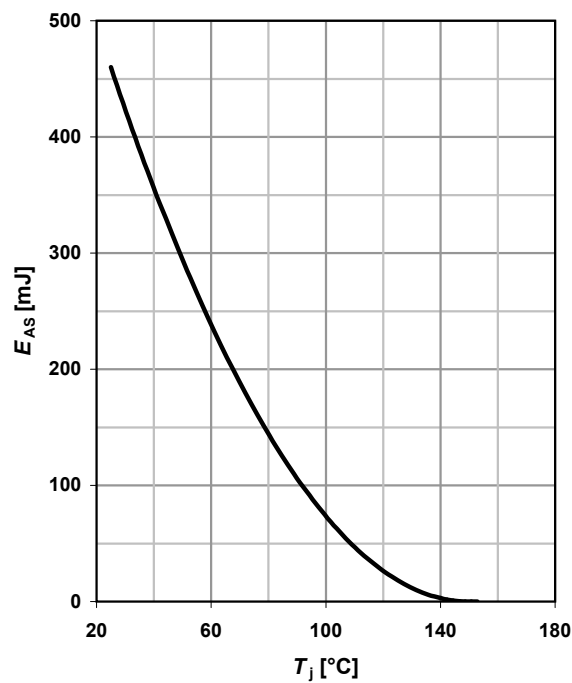
$$I_F=f(V_{SD})$$

parameter:  $T_j$



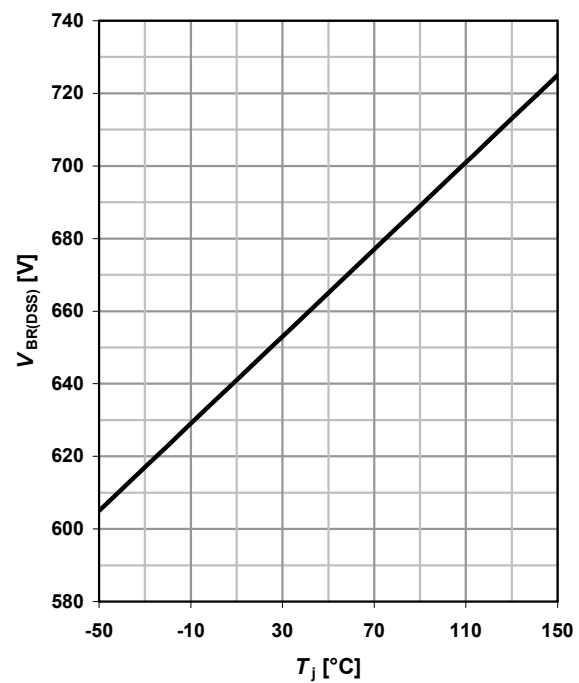
### 11 Avalanche energy

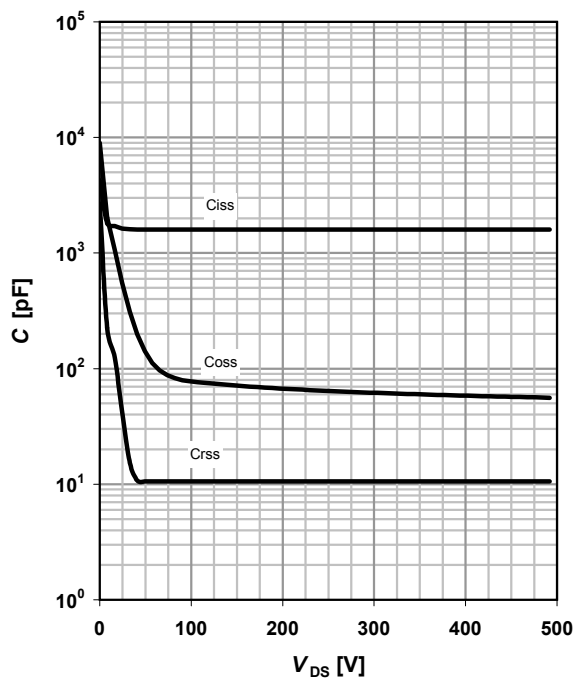
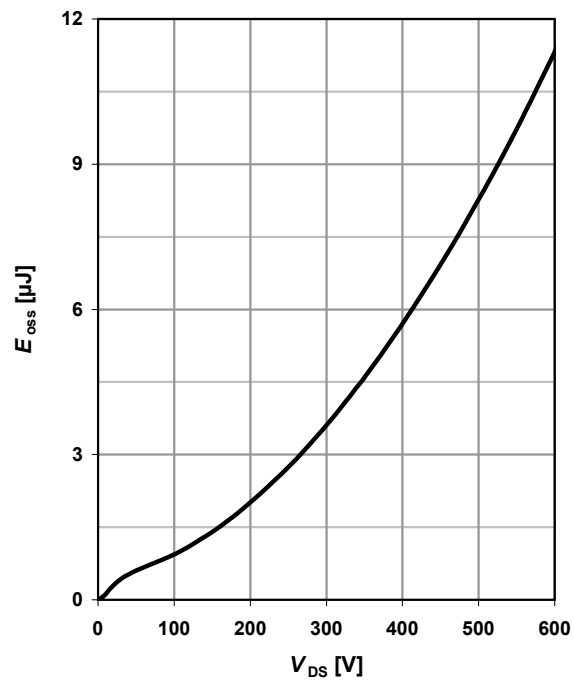
$$E_{AS}=f(T_j); I_D=3\text{ A}; V_{DD}=50\text{ V}$$



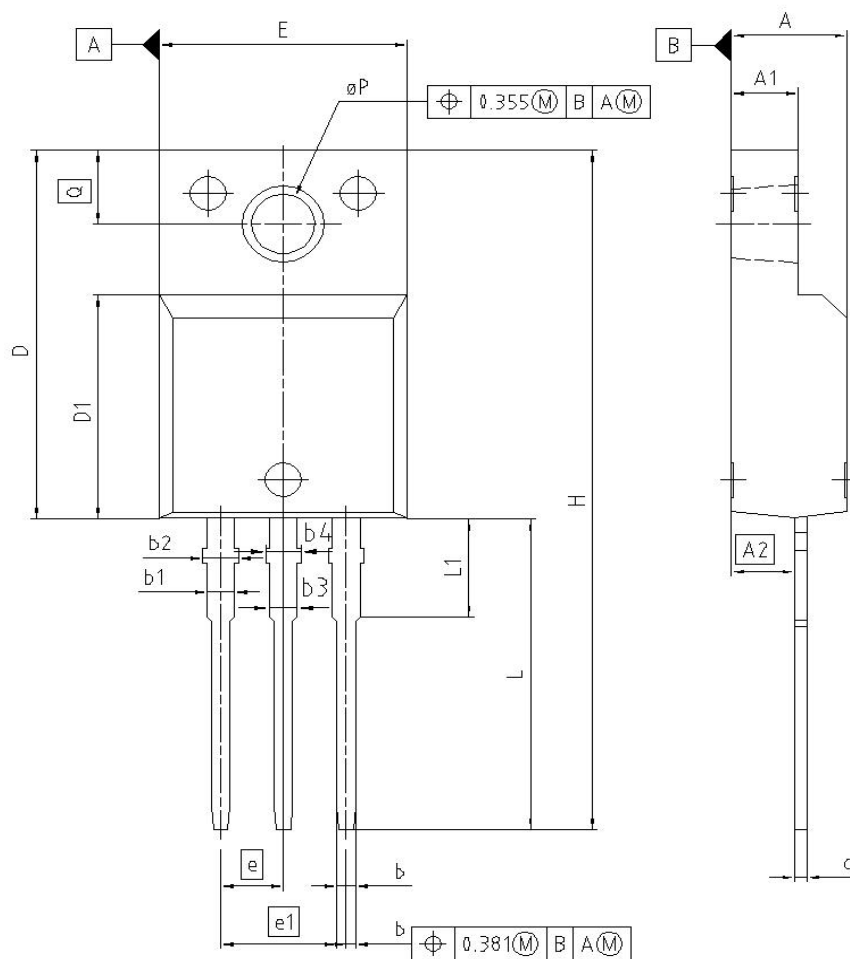
### 12 Drain-source breakdown voltage

$$V_{BR(DSS)}=f(T_j); I_D=0.25\text{ mA}$$

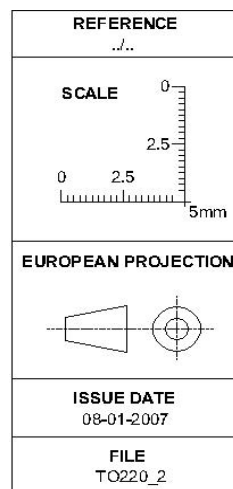


**13 Typ. capacitances**
 $C = f(V_{DS}); V_{GS} = 0 \text{ V}; f = 1 \text{ MHz}$ 

**14 Typ. Coss stored energy**
 $E_{oss} = f(V_{DS})$ 


**Definition of diode switching characteristics**


**PG-TO220-3-31/-3-111: Outline/Fully isolated package (2500VAC; 1 minute)**


| DIM | MILLIMETERS |       | INCHES |       |
|-----|-------------|-------|--------|-------|
|     | MIN         | MAX   | MIN    | MAX   |
| A   | 4.55        | 4.85  | 0.179  | 0.191 |
| A1  | 2.55        | 2.85  | 0.100  | 0.112 |
| A2  | 2.42        | 2.72  | 0.095  | 0.107 |
| b   | 0.65        | 0.85  | 0.026  | 0.033 |
| b1  | 0.95        | 1.33  | 0.037  | 0.052 |
| b2  | 0.95        | 1.51  | 0.037  | 0.059 |
| b3  | 0.65        | 1.33  | 0.026  | 0.052 |
| b4  | 0.65        | 1.51  | 0.026  | 0.059 |
| c   | 0.40        | 0.63  | 0.016  | 0.025 |
| D   | 15.85       | 16.15 | 0.624  | 0.636 |
| D1  | 9.53        | 9.83  | 0.375  | 0.387 |
| E   | 10.35       | 10.65 | 0.407  | 0.419 |
| e   | 2.54        |       | 0.100  |       |
| e1  | 5.08        |       | 0.200  |       |
| N   | 3           |       | 3      |       |
| H   | 29.45       | 29.75 | 1.159  | 1.171 |
| L   | 13.45       | 13.75 | 0.530  | 0.541 |
| L1  | 3.15        | 3.45  | 0.124  | 0.136 |
| pP  | 2.95        | 3.20  | 0.116  | 0.126 |
| Q   | 3.15        | 3.50  | 0.124  | 0.138 |



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